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| Form PTO 1449<br>Rev. 7-80 | U.S. Department of Commerce<br>Patent and Trademark Office<br><b>LIST OF PRIOR ART CITED BY APPLICANT</b><br>(Use Several Sheets If Necessary) | Atty. Docket No.<br>PO7963/MD-02-111               | Serial No. <u>10/696,458</u><br><del>To Be Assigned</del> |
|                            |  | Applicant<br>William E. Slack et al                |   |
|                            |  | Filing Date<br><del>Herewith</del> <u>10/29/03</u> | Group <u>1700</u>   |

## U.S. PATENT DOCUMENTS

| EXAMINER<br>INITIAL |    | DOCUMENT NUMBER | DATE     | NAME              | CLASS | SUBCLASS | FILING DATE<br>IF APPROPRIATE |
|---------------------|----|-----------------|----------|-------------------|-------|----------|-------------------------------|
| <i>RS</i>           | AA | 4,284,730       | 08/18/81 | Narayan et al     | 521   | 160      |                               |
| <i>RS</i>           | AB | 4,326,043       | 04/20/82 | Narayan et al     | 521   | 137      |                               |
| <i>RS</i>           | AC | 4,359,541       | 11/16/82 | Patton, Jr. et al | 521   | 137      |                               |
| <i>RS</i>           | AD | 4,359,550       | 11/16/82 | Narayan et al     | 524   | 871      |                               |
| <i>RS</i>           | AE | 4,379,905       | 04/12/83 | Stemmler et al    | 528   | 73       |                               |
| <i>RS</i>           | AF | 4,382,125       | 05/03/83 | Narayan et al     | 521   | 160      |                               |
| <i>RS</i>           | AG | 4,456,709       | 06/26/84 | Richter et al     | 521   | 160      |                               |
| <i>RS</i>           | AH | 4,518,761       | 05/21/85 | Richter et al     | 528   | 67       |                               |
| <i>RS</i>           | AI | 4,552,902       | 11/12/85 | Nafziger et al    | 521   | 129      |                               |
| <i>RS</i>           | AJ | 4,743,627       | 05/10/88 | Narayan et al     | 521   | 160      |                               |
| <i>RS</i>           | AK | 5,102,918       | 04/07/92 | Moriya            | 521   | 110      |                               |

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|           |    | DOCUMENT NUMBER | DATE     | COUNTRY       | CLASS | SUBCLASS | TRANSLATION |     |
|-----------|----|-----------------|----------|---------------|-------|----------|-------------|-----|
|           |    |                 |          |               |       |          | Yes         | No* |
| <i>RS</i> | AL | 1 337 659       | 11/21/73 | Great Britain |       |          |             |     |
| <i>RS</i> | AM | 2,113,890       | 08/19/94 | Canada        |       |          |             |     |
|           | AN |                 |          |               |       |          |             |     |
|           | AO |                 |          |               |       |          |             |     |
|           | AP |                 |          |               |       |          |             |     |

## OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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| EXAMINER <i>Ruben Lopez</i>   | DATE CONSIDERED <u>2/4/06</u> |
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| Form PTO 1449<br>Rev. 7-80  | U.S. Department of Commerce<br>Patent and Trademark Office | Atty. Docket No.<br>PO7963/MD-02-11      | Serial No. <u>10/696,458</u><br><del>To Be Assigned</del> |
| LIST OF PRIOR ART CITED BY APPLICANT<br>(Use Several Sheets If Necessary) |  | Applicant<br>William E. Slack et al      |   |
|   |  | Filing Date<br>Here with <u>10/29/03</u> | Group<br><u>1700</u>                                      |

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| <i>RS</i>           | AA | 5,124,370       | 06/23/92 | Scholl et al   | 521   | 161      |                               |
| <i>RS</i>           | AB | 5,723,564       | 03/03/98 | (Bel. to corresp. to DE 195,23,837)<br>Schmalstieg et al | 528   | 73       |                               |
| <i>RS</i>           | AC | 5,798,431       | 08/25/98 | Brahm et al  | 528   | 73       |                               |
| <i>RS</i>           | AD | 6,028,158       | 02/22/00 | Slack et al  | 528   | 44       |                               |
| <i>RS</i>           | AE | 6,063,891       | 05/16/00 | Slack et al  | 528   | 59       |                               |
| <i>RS</i>           | AF | 6,515,125 B1    | 02/04/03 | Slack et al  | 544   | 222      |                               |
|                     | AG |                 |          |  |       |          |                               |
|                     | AH |                 |          |  |       |          |                               |
|                     | AI |                 |          |  |       |          |                               |
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|  |    |                 |      |         |       |          | Yes         | No* |
|  | AL |                 |      |         |       |          |             |     |
|  | AM |                 |      |         |       |          |             |     |
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| EXAMINER <i>Kabon Bryant</i>  | DATE CONSIDERED <u>2/4/06</u> |
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Rev. 7-80U.S. Department of Commerce  
Patent and Trademark OfficeLIST OF PRIOR ART CITED BY APPLICANT  
(Use Several Sheets If Necessary)Atty. Docket No  
PO-7963/MD-02-111Serial No.  
10/696,458Applicant  
William E. Slack et alFiling Date  
October 29, 2003Group  
1711

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| RS                  | AA | 6,515,125 B1    | 02/04/03 | (Ref. to corresp. to US<br>Slack et al | 2003/013894-<br>544 | 222      |                               |
|                     | AB |                 |          |  |                     |          |                               |
|                     | AC |                 |          |  |                     |          |                               |
|                     | AD |                 |          |  |                     |          |                               |
|                     | AE |                 |          |  |                     |          |                               |
|                     | AF |                 |          |  |                     |          |                               |
|                     | AG |                 |          |  |                     |          |                               |
|                     | AH |                 |          |  |                     |          |                               |
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*Robert J. ...*

DATE CONSIDERED

2/4/06

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